



TEST/CALIBRATION REPORT



ELECTRONICS REGIONAL TEST LABORATORY (WEST)
MINISTRY OF COMMUNICATIONS & INFORMATION TECHNOLOGY, (STQC Dte.)

Government of India

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MEMORANDUM

The Test/Calibration Report issued by ERTL (W) is a record of the measurements conducted on the products submitted to it for testing / calibration and the results thereof. Unless otherwise specified in the report, the results are applicable only to those products which have been tested / calibrated and do not apply to other products even though declared to be identical.

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LIABILITY CLAUSE

1. ERTL(W) shall not be liable for any change in test/calibration data and performance specification on account of malfunctioning of the standard / instrument / equipment due to any damage caused to it after the report, in respect of it has been issued.
2. The report shall not be regarded in any way diminishing the normal contractual responsibilities / obligations between the customer and ERTL (W).
3. The results reported in this report are valid only at the time of and under the stated conditions of the measurements.

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1. SCOPE

1.1 Service Request No : ERTL(W) / 2005 1345 Dated. 10th August, 2005

1.1.1 Service Request finalised on : 10th August, 2005

1.2 Requested by (Name and address of organisation) : SETO TEKNOLOG PVT LTD.
406, HILL VIEW INDL. ESTATE
OFF. LBS MARG, AMRUT NAGAR
GHATKOPAR(W), MUMBAI 400086

1.3	Description	Qty	Manufacturer	Type No.	Serial Nos.
	Current Transducer I/P: 0-5A AC, O/P: 4-20 mA DC, Aux. Supply: 230 V AC Class: 0.5 Category: II, Isolation: 4 kV	01	SETO No. TEKNOLOG PVT LTD.	STE-A-1T	350988

1.4 Test specifications : IEC 60688 (Limited Parameters)

1.5 Lab Ambient : Temperature: (25 ±2) deg. C
RH : (55 ±5) % RH

1.6 Test Equipment used

1. Power Energy Calibrator (E&S/126)
2. High Voltage Tester (E&S/66)
3. Impulse Voltage Tester (COM/209)
4. Variac (E&S/99)
5. Clamp Meter (SAF/137)
6. Magnetic Influence Jig
7. Timer

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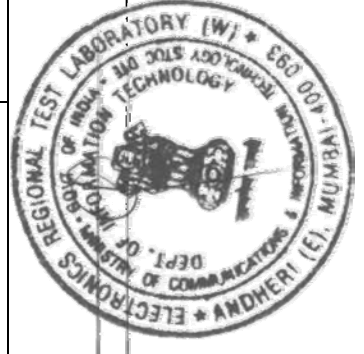


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2.0 Test Results.

Sr.No.	Test/Parameter (Clause No.)	Test Condition	Requirement	Observation	Remark
2.1	Intrinsic error (4.2)	Aux. Supply Voltage: 230V AC a) Input current = 0.5A AC b) Input current = 2.5 A AC c) Input current = 5 A AC	Class index (0.5 %) ±0.080 mA (Max)	See Annexure -I	Complied
2.2	Variation due to ambient temp. (6.4)	a) Temp. 25 deg. C b) Temp. 0 deg. C c) Temp. 50 deg. C	100% of class index ±0.080 mA (Max)	See Annexure -I	Complied
2.3	Variation due to distortion of input quantities (6.10)	a) I/p without distortion b) I/p with 20 % 3 rd harmonics	200% of Class index ±0.160 mA (Max)	See Annexure -I	Complied
2.4	Variation due to magnetic field of external origin (6.11)	a) Without magnetic field b) With Magnetic field of 0.4 kA/m	100 % of class index ±0.080 mA (Max)	See Annexure -I	Complied

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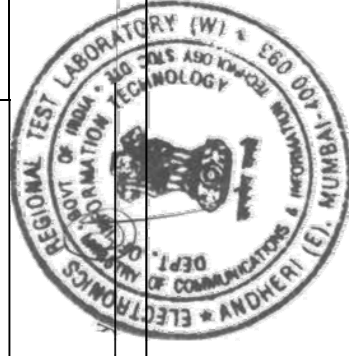


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2.0 Test Results. (continued)

Str.No.	Test/Parameter (Clause No.)	Test Condition	Requirement	Observation	Remark
2.5	Permissive excessive inputs (6.18)				
2.5.1	Continuous excessive inputs (6.18.1)	Apply 120 % of nominal upper value on current inputs & Auxiliary Supply	Continue to comply the accuracy class after test	See Annexure -I	Complied
2.5.2	Excessive inputs of short duration (6.18.2)	For current inputs: 20 times the nominal value of the measured current applied for 1 s and repeated 5 times at 300 s interval	Continue to comply the accuracy class after test	See Annexure -I	Complied
2.6	Voltage test (6.19)	At 4 kV AC for 1 min. between Input & output	There shall be no breakdown.	No flash over or breakdown observed.	Complied

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Sr.No.	Test/Parameter (Clause No.)	Test Condition	Requirement	Observation	Remark
2.7	Impulse voltage tests (6.20)	At peak test voltage of 5 kV in both positive and negative senses having the standardized impulse waveform of 1.2/50 us, applied between terminals of each circuit in turn and all other circuit connected together.	There shall be no flashover or breakdown.	No flashover or break down observed	Complied
2.7.1	Intrinsic error (4.2)	As in 2.1 above	Class index (0.5 %) ± 0.080 mA (Max)	See Annexure -I	Complied
2.8	High frequency disturbance test (6.21)	2.5 kV peak between independent circuits. 1kV peak between terminals of the same circuit.	The variation due to the effect of disturbance shall not be twice of class index.	See Annexure -I	Complied
2.8.1	Intrinsic error (4.2)	As in 2.1 above	Class index (0.5 %) ± 0.080 mA (Max)	See Annexure -I	Complied

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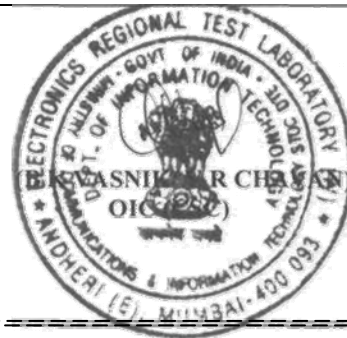
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3.0 General Remarks : - NIL -

REPORT APPROVED BY

REPORT RELEASED BY

Abdul Moideen
ABDUL MOID
HEAD (E&S)



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ANNEXURE –I

OUTPUT at 25 deg C				Output after Impulse Test	
INPUT (A)	STD. (mA DC)	OBS. (mA DC)	Error	OBS. (mA)	Variation
0.5	5.560	5.591	0.031	5.579	0.012
2.5	12.000	11.993	0.007	11.993	0.000
5	20.000	19.996	0.004	20.014	0.018
Output at 0 deg C				Output at 45 deg C	
INPUT (A)	STD. (mA DC)	OBS. (mA DC)	Error	OBS. (mA)	Variation
0.5	5.560	5.581	0.010	5.583	0.008
2.5	12.000	11.986	0.007	11.973	0.020
5	20.000	19.983	0.013	19.975	0.021
Output with Magnetic field				Output at 3rd Harm	
INPUT (A)	STD. (mA DC)	OBS. (mA DC)	Error	OBS. (mA)	Variation
0.5	5.560	5.578	0.013	5.635	0.044
2.5	12.000	11.969	0.024	11.969	0.024
5	20.000	19.965	0.031	20.022	0.026
O/p after Cont. Excessive input				O/P after excessive input of short duration	
INPUT (A)	STD. (mA DC)	OBS. (mA DC)	Error	OBS. (mA)	Variation
0.5	5.560	5.585	0.006	5.589	0.002
2.5	12.000	11.989	0.004	11.992	0.001
5	20.000	20.014	0.018	20.004	0.008
Output after HF Disturbance.					
INPUT (A)	STD. (mA DC)	OBS. (mA DC)	Variation		
0.5	5.560	5.585	0.006		
2.5	12.000	11.989	0.004		
5	20.000	20.014	0.018		

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OUR ACCREDITATION STATUS

ERTL (WJ set tip under the STQC Directorate, Ministry of Communications & Information Technology, Govt of India has been accredited under number of national / international systems as follows :

SYSTEM	AREA	STATUS
IECQ [International Electro-technical Commission on Quality Assessment System for Electronic Components)	Component Testing • Resistors (Fixed) • Capacitors (Fined)	Accredited as ITL (Independent Test Laboratory)
NABL(C), India National Accreditation Board for Test & Calibration laboratories (Calibration System)	Calibration • Eteciro-technical discipline • Thermal discipline • Mechanical discipline	Accredited Calibration Laboratory
NABL (T). India National Accreditation Board for Test & Calibration laboratories (Testing System)	Electronic & Electrical Testing	Accredited Test Laboratory
IECEE-CB-Scheme	• Wains Operated Electronic Consumer Products • IT Products • Safely critical components	Approved as a CB Test Laboratory
SASO	Electronics & Electrical Testing	Recognised by Saudi Arabian Standard Organisation
Other recognitions	Electronics & Electrical Testing	Recognised by CSPO of State Govt., DOT. OGS & D, LCSO, RDSO. DRDO and BIS.